TOSHIBA Transistor Silicon NPN Triple Diffused Type

# **TPCP8503**

### **High-Voltage Switching Applications**

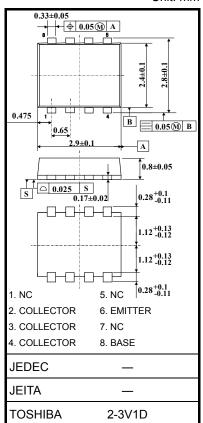
Unit: mm

- High breakdown voltage: VCEO = 600 V
- Low saturation voltage:  $V_{CE (sat)} = 1.0 \text{ V (max)}$  (IC = 20 mA, IB = 0.5 mA)

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		$V_{CBO}$	600	V	
Collector-emitter voltage		V <sub>CEO</sub>	600	V	
Emitter-base voltage		V <sub>EBO</sub>	7	V	
Collector current (Note 1)	DC	IC	50	mA	
	Pulse	I <sub>CP</sub>	100		
Base current		ΙB	25	mA	
Collector power dissipation (Note 2)	t=10s	Pc	2.2	W	
	DC	FC	1.1	W	
Junction temperature		Tj	150	°C	
Storage temperature range		T <sub>stg</sub>	−55 to 150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e.



Weight: 0.36 g (typ.)

operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

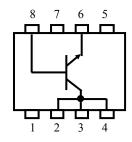
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

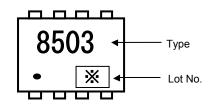
## **Electrical Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	V <sub>CB</sub> = 600 V, I <sub>E</sub> = 0	_	_	100	μΑ
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> = 7 V, I <sub>C</sub> = 0	_	_	100	μΑ
Collector-emitter breakdown voltage	V <sub>CEO</sub>	I <sub>C</sub> = 1 mA, I <sub>B</sub> = 0	600	_	_	V
DC current gain	h <sub>FE (1)</sub>	V <sub>CE</sub> = 5 V, I <sub>C</sub> = 1 mA	80	_	_	
	h <sub>FE (2)</sub>	V <sub>CE</sub> = 5 V, I <sub>C</sub> = 20 mA	100	_	300	
Collector-emitter saturation voltage	V <sub>CE</sub> (sat)	I <sub>C</sub> = 20 mA, I <sub>B</sub> = 0.5 mA	_	_	1.0	V
Base-emitter voltage	V <sub>BE</sub>	V <sub>CE</sub> = 5 V, I <sub>C</sub> = 20 mA	_	_	1.1	V
Collector output capacitance	C <sub>ob</sub>	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0, f = 1 MHz	1	5.5	_	pF

Figure 1. Circuit Configuration

Figure 2. Marking (Note 3)



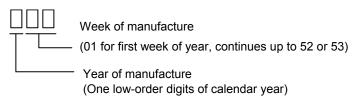


Note 1 : Please use devices on condition that the junction temperature is below 150°C.

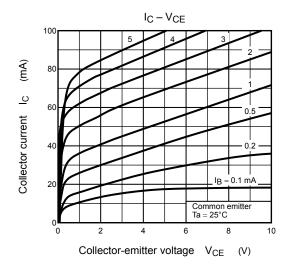
Note 2: Mounted on FR4 board( glass epoxy, 1.6mm thick, Cu area: 645mm<sup>2</sup>)

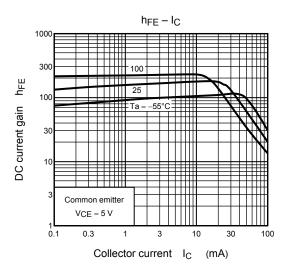
Note 3 :● on lower left of the marking indicates Pin 1.

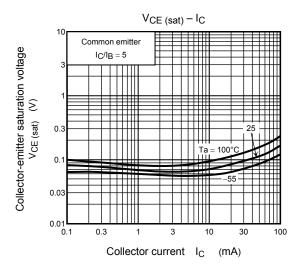
Weekly code: (three digits)

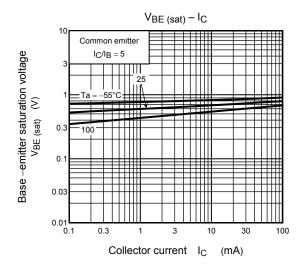


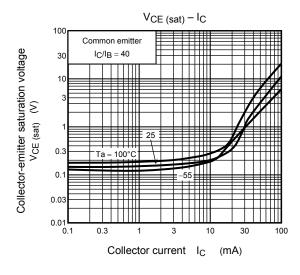
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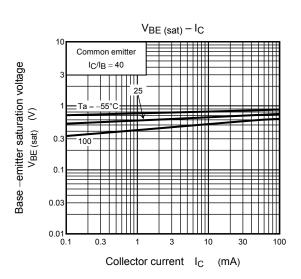


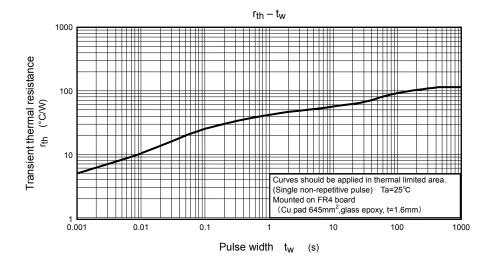


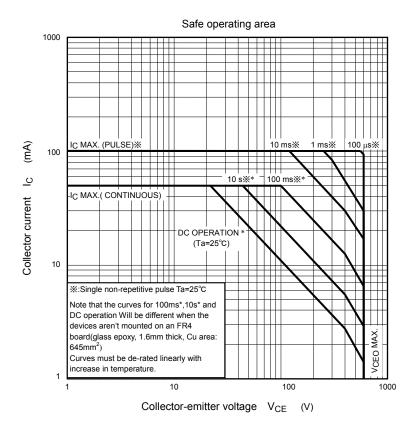












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